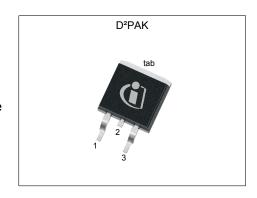


MOSFET

600V CoolMOS™ P7 Power Transistor

The CoolMOS™ 7th generation platform is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. The 600V CoolMOS™ P7 series is the successor to the CoolMOS™ P6 series. It combines the benefits of a fast switching SJ MOSFET with excellent ease of use, e.g. very low ringing tendency, outstanding robustness of body diode against hard commutation and excellent ESD capability. Furthermore, extremely low switching and conduction losses make switching applications even more efficient, more compact and much cooler.



Features

- Suitable for hard and soft switching (PFC and LLC) due to an outstanding commutation ruggedness
- Significant reduction of switching and conduction losses
- Excellent ESD robustness >2kV (HBM) for all products
- Better R_{DS(on)}/package products compared to competition enabled by a low R_{DS(on)}*A (below 10hm*mm²)

Benefits

- Ease of use and fast design-in through low ringing tendency and usage across PFC and PWM stages
- Simplified thermal management due to low switching and conduction losses
- Increased power density solutions enabled by using products with smaller footprint and higher manufacturing quality due to >2 kV ESD protection
- Suitable for a wide variety of applications and power ranges

PB

Gate





Drain

Source

Potential applications

PFC stages, hard switching PWM stages and resonant switching stages for e.g. PC Silverbox, Adapter, LCD & PDP TV, Lighting, Server, Telecom and UPS.

Product validation

Fully qualified according to JEDEC for Industrial Applications

Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.

Table 1 Key Performance Parameters

Table 1 Rey Let Tollilance Latameters								
Value	Unit							
650	V							
45	mΩ							
90	nC							
206	A							
9.4	μJ							
900	A/µs							
	Value 650 45 90 206 9.4							

Type / Ordering Code	Package	Marking	Related Links
IPB60R045P7	PG-TO 263-3	60R045P7	see Appendix A

600V CoolMOS™ P7 Power Transistor IPB60R045P7



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600V CoolMOS™ P7 Power Transistor IPB60R045P7



1 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 Maximum ratings

Davamastan	Values			S	11		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current ¹⁾	I _D	-	-	61 38	А	T _C =25°C T _C =100°C	
Pulsed drain current ²⁾	I _{D,pulse}	-	-	206	Α	T _C =25°C	
Avalanche energy, single pulse	E _{AS}	-	-	217	mJ	I _D =8.5A; V _{DD} =50V; see table 10	
Avalanche energy, repetitive	E AR	-	-	1.08	mJ	I _D =8.5A; V _{DD} =50V; see table 10	
Avalanche current, single pulse	I _{AS}	-	-	8.5	Α	-	
MOSFET dv/dt ruggedness	dv/dt	-	-	80	V/ns	V _{DS} =0400V	
Gate source voltage (static)	V _{GS}	-20	-	20	V	static;	
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P _{tot}	-	-	201	W	<i>T</i> _C =25°C	
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-	
Operating junction temperature	T _j	-55	-	150	°C	-	
Mounting torque	-	-	-	-	Ncm	-	
Continuous diode forward current	Is	-	-	61	Α	<i>T</i> _C =25°C	
Diode pulse current ²⁾	I _{S,pulse}	-	-	206	Α	<i>T</i> _C =25°C	
Reverse diode dv/dt ³⁾	dv/dt	-	-	50	V/ns	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <=61A, $T_{\rm j}$ =25°C see table 8	
Maximum diode commutation speed	di₅/dt	-	-	900	A/μs	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <=61A, $T_{\rm j}$ =25°C see table 8	
Insulation withstand voltage	V _{ISO}	-	-	n.a.	V	V _{rms} , T _C =25°C, t=1min	

 $^{^{1)}}$ Limited by $T_{j,max}.$ Maximum Duty Cycle D = 0.50; TO-220 equivalent $^{2)}$ Pulse width t_p limited by $T_{j,max}$ $^{3)}$ Identical low side and high side switch with identical $R_{\rm G}$

IPB60R045P7



2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Values				11:4	Nata / Tank Canadition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.62	°C/W	-
Thermal resistance, junction - ambient	R _{thJA}	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	R_{thJA}	-	35	45	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.
Soldering temperature, wavesoldering only allowed at leads	T _{sold}	-	-	260	°C	reflow MSL1

600V CoolMOS™ P7 Power Transistor IPB60R045P7



3 Electrical characteristics at T_j =25°C, unless otherwise specified

Table 4 **Static characteristics**

Parameter	Oh o.l		Values			Nets / Test Ossalition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	600	-	-	V	V_{GS} =0V, I_D =1mA
Gate threshold voltage	V _{(GS)th}	3	3.5	4	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 1.08 \rm mA$
Zero gate voltage drain current	I _{DSS}	-	- 10	1 -	μΑ	V _{DS} =600V, V _{GS} =0V, T _j =25°C V _{DS} =600V, V _{GS} =0V, T _j =150°C
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	0.038 0.088	0.045	Ω	V _{GS} =10V, I _D =22.5A, T _j =25°C V _{GS} =10V, I _D =22.5A, T _j =150°C
Gate resistance	R _G	-	2	-	Ω	f=1MHz, open drain

Dynamic characteristics Table 5

Parameter	Ob. a.l		Values			Nata / Tant Can dition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	C _{iss}	-	3891	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz
Output capacitance	Coss	-	63	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz
Effective output capacitance, energy related ¹⁾	C _{o(er)}	-	117	-	pF	V _{GS} =0V, V _{DS} =0400V
Effective output capacitance, time related ²⁾	C _{o(tr)}	-	1212	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0400V
Turn-on delay time	t _{d(on)}	-	27	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =22.5A, $R_{\rm G}$ =3.0Ω; see table 9
Rise time	t _r	-	12	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =22.5A, $R_{\rm G}$ =3.0 Ω ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	88	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =22.5A, $R_{\rm G}$ =3.0Ω; see table 9
Fall time	t _f	-	4	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =22.5A, $R_{\rm G}$ =3.0 Ω ; see table 9

Table 6 **Gate charge characteristics**

Parameter	Comple ed		Values			Nata / Tast Canditian
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	20	-	nC	V_{DD} =400V, I_{D} =22.5A, V_{GS} =0 to 10V
Gate to drain charge	$Q_{ m gd}$	-	28	-	nC	V_{DD} =400V, I_{D} =22.5A, V_{GS} =0 to 10V
Gate charge total	Q g	-	90	-	nC	V_{DD} =400V, I_{D} =22.5A, V_{GS} =0 to 10V
Gate plateau voltage	V _{plateau}	-	5.2	-	V	V_{DD} =400V, I_{D} =22.5A, V_{GS} =0 to 10V

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400V

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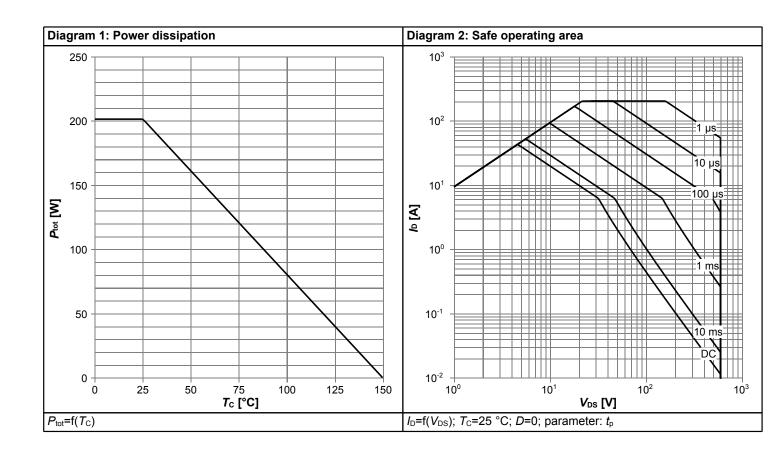


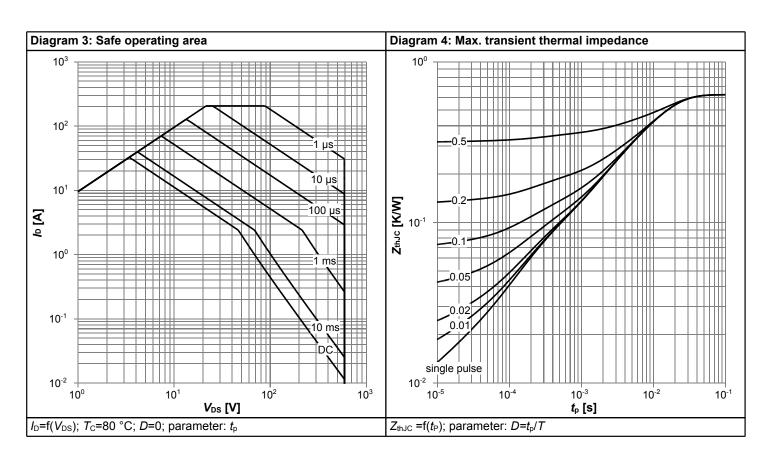
Table 7 Reverse diode characteristics

Parameter	Cumbal	Values			11	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	V _{SD}	-	0.9	-	V	V _{GS} =0V, I _F =22.5A, T _j =25°C
Reverse recovery time	t _{rr}	-	277	-	ns	V_R =400V, I_F =8A, di_F/dt =100A/ μ s; see table 8
Reverse recovery charge	Qrr	-	3.6	-	μC	V_R =400V, I_F =8A, di_F/dt =100A/ μ s; see table 8
Peak reverse recovery current	I _{rrm}	-	26.8	-	А	V_R =400V, I_F =8A, di_F/dt =100A/ μ s; see table 8

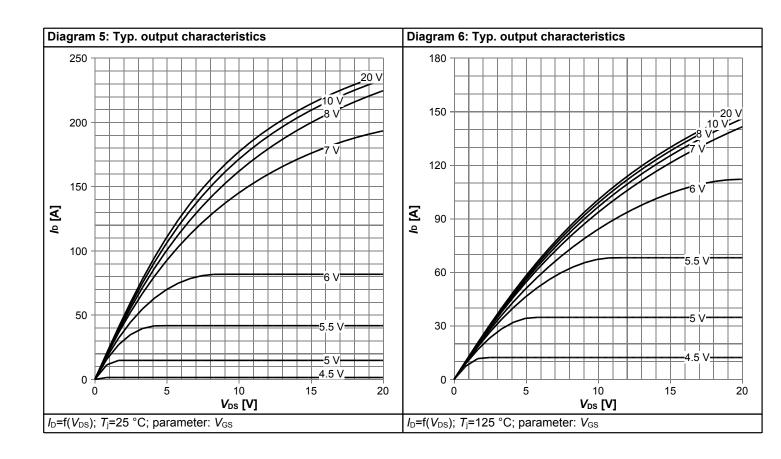


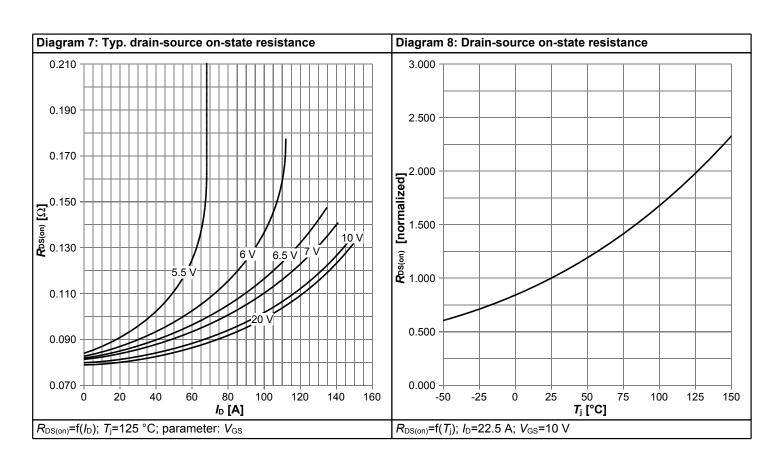
4 Electrical characteristics diagrams



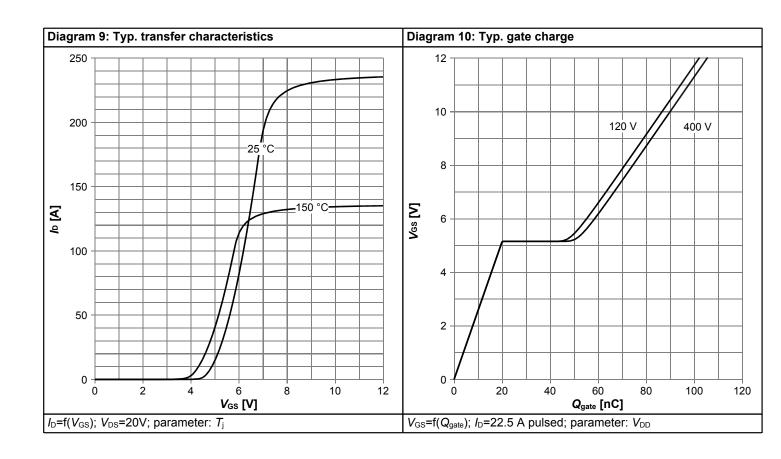


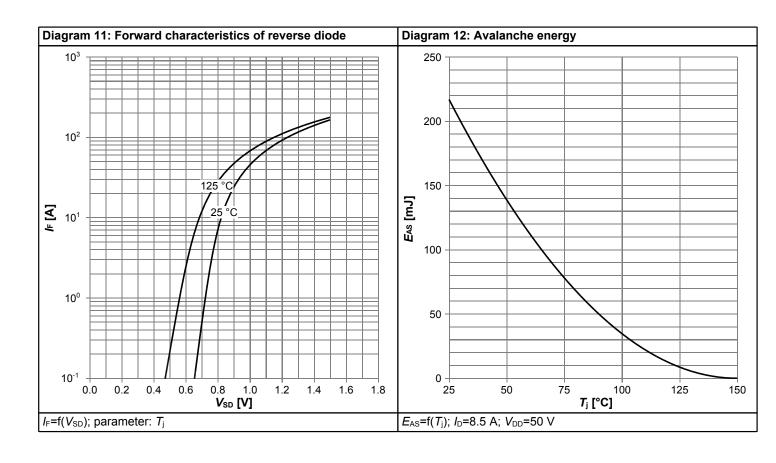




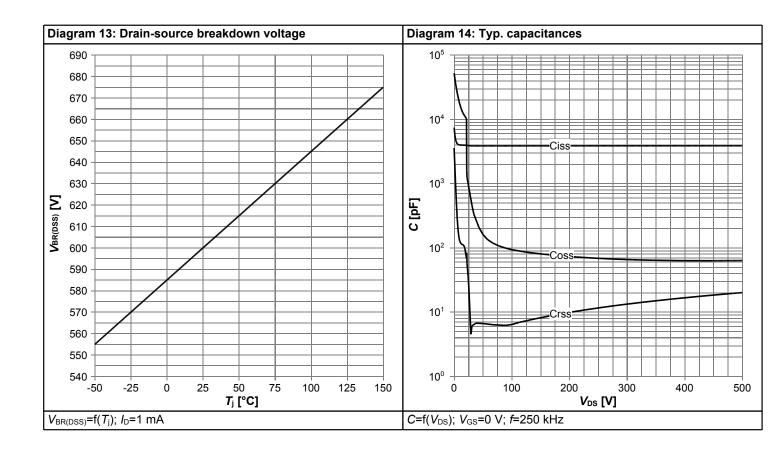


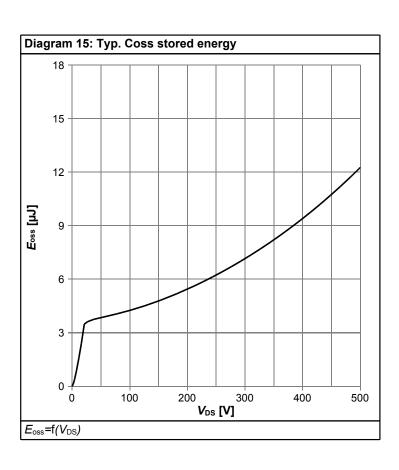
















5 **Test Circuits**

Table 8 **Diode characteristics**

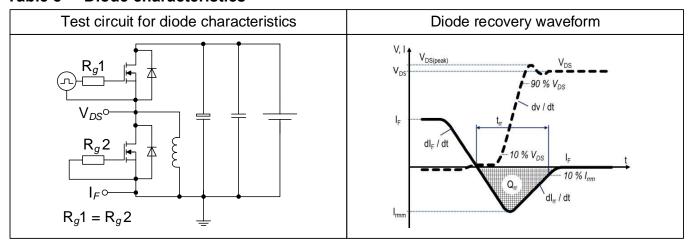
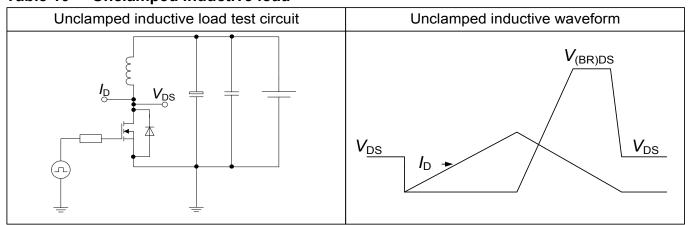


Table 9 **Switching times**



Table 10 **Unclamped inductive load**





6 Package Outlines

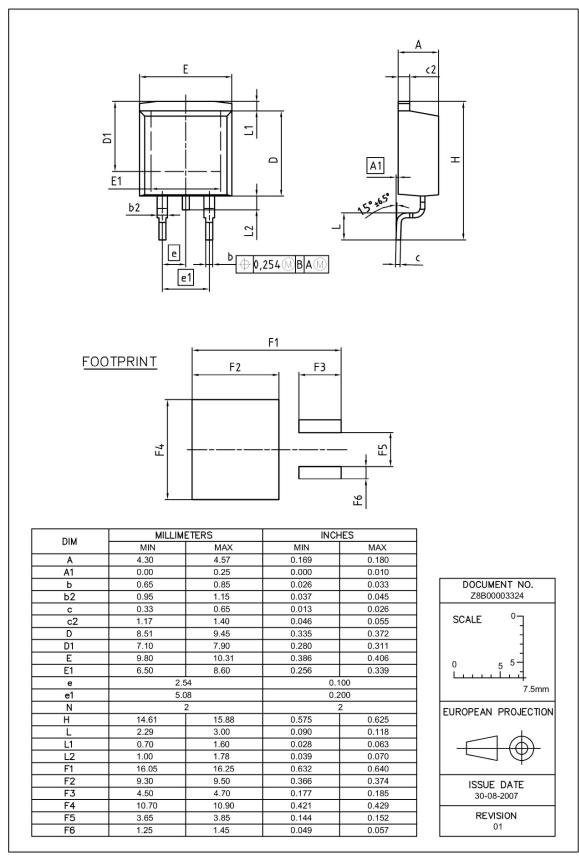


Figure 1 Outline PG-TO 263-3, dimensions in mm/inches





7 Appendix A

Table 11 Related Links

• IFX CoolMOS P7 Webpage: www.infineon.com

• IFX CoolMOS P7 application note: www.infineon.com

• IFX CoolMOS P7 simulation model: www.infineon.com

• IFX Design tools: www.infineon.com





Revision History

IPB60R045P7

Revision: 2019-02-28, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
2.0	2019-02-28	Release of final version				

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Final Data Sheet 14 Rev. 2.0, 2019-02-28